Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination  LAFORTUNE, JEFFREY MARK	
10/747,924		
Examiner	Art Unit	
Matthew D. Matzek	. 1771	

SEARCHED			
Class	Subclass	Date	Examiner
427	532,533	8/1/2005	мм
428	847.5	8/1/2005	ММ
442	59,74,76	8/1/2005	ММ
	118,121	8/1/2005	MM
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(INCLUDING SEA	H NOTES ARCH STRATEG	Y)
	DATE	EXMR
Inventor/Assignee	8/2/2005	мм
	6/28/06	MM
EAST	8/1/2005	MM
DITAGES	1/10/06	им
iDS ,	8/1/2005	мм

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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